



## Product Change Notification - LIAL-30MNIK231

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**Date:**

03 Feb 2020

**Product Category:**

Memory

**Affected CPNs:****Notification subject:**

Memo # ML01202000QB: Final Notice: Qualification of 36.3K process technology for selected Microchip products of the 24xx08 and 24xx16 device families.

**Notification text:****PCN Status:**

Final notification

**PCN Type:**

Manufacturing Change

**Microchip Parts Affected:**

Please open one of the icons found in the Affected CPNs section above.

**NOTE:** For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**

Qualification of 36.3K process technology for selected Microchip products of the 24xx08 and 24xx16 device families.

**Pre Change:**

Available in 160K wafer technology fabricated at Microchip fabrication sites FAB2 and FAB4 (Tempe, AZ and Gresham, OR, USA) using 8 inch wafers

**Post Change:**

Available in 160K wafer technology fabricated at Microchip fabrication sites FAB2 and FAB4 (Tempe, AZ and Gresham, OR, USA) using 8 inch wafers or available in 36.3K wafer technology fabricated at FAB 5 (Colorado Springs, CO, USA) using 6 inch wafers.

**Pre and Post Change Summary:**

	Pre Change	Post Change	
<b>Wafer Technology</b>	160K wafer technology	160K wafer technology	36.3K wafer technology
<b>Fabrication Location</b>	Microchip Fabrication Sites FAB 2 and FAB4 (Tempe, AZ and Gresham, OR, USA)	Microchip Fabrication Sites FAB 2 and FAB4 (Tempe, AZ and Gresham, OR, USA)	FAB 5 (Colorado Springs, CO USA)
<b>Wafer Diameter</b>	8 inches (200 mm)	8 inches (200 mm)	6 inches (150 mm)
<b>Quality certification</b>	ISO/TS16949	ISO/TS16949	ISO9001/TS16949



**Impacts to Data Sheet:**

None

**Change Impact:**

None

**Reason for Change:**

To improve manufacturability by qualifying an additional fabrication site.

**Change Implementation Status**

In Progress

**Estimated First Ship Date:**

April 15, 2020 (date code: 2016)

NOTE: Please be advised that after the estimated first ship date customers may receive pre and post change parts

**Time Table Summary:**

	February 2020				->	April 2020				
Workweek	06	07	08	09		14	15	16	17	18
Final PCN Issue Date	x									
Qual Report Availability	x									
Estimated Implementation Date								X		

**Method to Identify Change:**

Traceability code

**Qualification Report:**

Please open the attachments included with this PCN labeled as PCN\_#\_Qual Report.

**Revision History:**

**February 3, 2020:** Issued final notification. Attached the qualification report. Provided estimated first ship date to be on April 15, 2020.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

**Attachment(s):**

[PCN\\_LIAL-30MNIK231\\_QUAL\\_REPORT.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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**QUALIFICATION REPORT SUMMARY  
RELIABILITY LABORATORY**

**PCN#: LIAL-30MNIK231**

**Date  
December 3, 2019**

**Qualification of 36.3K process technology for selected  
Microchip products of the 24xx08 and 24xx16 device families.**



**MICROCHIP**

## **SUMMARY QUALIFICATION REPORT**

**Purpose:** Qualification of 36.3K process technology for selected Microchip products of the 24xx08 and 24xx16 device families.

**Document Control #:** ML122019000C

**Document Revision:** A

**Device(s):** AT24x08/AT24x16/24xx08x/24xx16x

**Product:** 5V 2W 16K serial EEPROM

**Mask Identification #:** 363V4

**Process** 0.25um, 6" wafer

**MSL:** 3301



**MICROCHIP**

## SUMMARY QUALIFICATION REPORT

### Qualification Material:

LOT	LOT 1
DEVICE	24AA16-E/P
MASK, REV	363V4 (A2)
WAFER FAB	Fab 5
WAFER PROCESS	0.25um, 6"
WAFER LOT	MCSO520188047.000
ASSEMBLY LOT	MMT-202100278.000
PACKAGE	8LD PDIP
ASSEMBLY SITE	MMT
FINAL TEST	MTAI
QUAL #	ESD: ML0920190079 LU: ML092019007A CDM: ML102019003B
QUAL TEST	HTOL / ELFR / HTDR / ESD / LU / CDM

### Conclusion:

Pass  Fail

Based on the results, the 363V4 mask has meet the reliability guidelines implemented in the qualification plan.

## Qualification Data:

### Early Life Failure Rate (ELFR):

Test Method	AEC Q100-008
Test Condition	125°C / 24 hours
Sample Size (800 ea. min)	(Fail/Pass)
Lot 1	0 / 815

Pre & Post Testing was done @ +25°C, -40°C, +85°C, and 125°C.

### High Temperature Operating Life (HTOL)

Test Method	AEC Q100-005
Test Condition	125°C / 408 hours
Sample Size (77 ea. min)	(Fail/Pass)
Lot 1	0 / 615

Pre & Post Testing was done @ +25°C, -40°C, +85°C, and 125°C.

### High Temperature Data Retention (HTDR)

Test Method	AEC Q100-005
Test Condition	125°C / 504 hours
Sample Size (231 ea. min)	(Fail/Pass)
Lot 1	0 / 246

Pre & Post Testing was done @ +25°C, -40°C, +85°C, and 125°C.

### ESD and Latch Up

Test	Reference Method	Sample	Highest Passing Voltage
ESD – HBM	AEC Q100-002 JS-001-2017	18/Lot 1	+/- 4500V
ESD – CDM	AEC Q100-11 (ANSI/ESD S5.3.1)	18/Lot 1	+/- 2000V on all pins
Latch Up	AEC Q100-004 JEDEC JESD78	6/Lot 1 6/Lot 1 6/Lot 1	6 Pass @ +25°C <sup>a</sup> 6 Pass @ +125°C <sup>a</sup> 6 Pass @ +25°C <sup>b</sup>

All Pre & Post Testing done @ +25°C, +85°C, and 125°C.

<sup>a</sup> +/-105mA Pulse / +Overvoltage stress

<sup>b</sup> +/-200mA Pulse / +Overvoltage stress

**MTBF/FIT Data:**

<b>These calculations only consider ELFR and DLT data from this Qualification</b>	
Activation Energy	0.7 eV
Application Temperature	55 degrees C

	Infant Mortality	Total Life	MTBF (Hours)
Device Hours	19,560	270,480	N/A
Fit Rate - 50% Confidence	136	10	101,595,911
Fit Rate - 60% Confidence	180	13	76,854,340
Fit Rate - 90% Confidence	452	33	30,583,417

Note: One FIT is one fail in 10<sup>9</sup> device hours

	Best Estimated Failure Rate (%KHR)
Infant Mortality	0.0136
Total Life	0.0010



Affected Catalog Part Numbers (CPN)

24LC16BH-I/P  
24AA16H-I/P  
24LC16BH-I/ST  
24AA16H-I/ST  
24LC16BHT-I/MNY  
24AA16HT-I/MNY  
24LC16BHT-I/MS  
24AA16HT-I/MS  
24LC16BHT-I/SN  
24AA16HT-I/SN  
24LC16BHT-I/ST  
24AA16HT-I/ST  
24LC16BHT-I/OT  
24AA16HT-I/OT  
24LC16BHT-E/MNY  
24LC16BHT-E/MS  
24LC16BHT-E/SN  
24LC16BHT-E/ST  
24LC16BHT-E/OT  
24LC08B/SN  
24AA08/SN  
24LC08B/P  
24AA08/P  
24LC08B/ST  
24LC08B-E/MS  
24LC08B-E/MC  
24LC08B-E/SN  
24LC08B-E/P  
24LC08B-E/ST  
24LC08B-I/MS  
24AA08-I/MS  
24LC08B-I/MC  
24AA08-I/MC  
24LC08B-I/SN  
24AA08-I/SN  
24LC08B-I/P  
24AA08-I/P  
24LC08B-I/ST  
24AA08-I/ST  
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24AA08T/SN  
24LC08BT/ST  
24LC08BT-I/MNY  
24AA08T-I/MNY  
24LC08BT-I/MS  
24AA08T-I/MS

24LC08BT-I/MC  
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24AA08H-I/P  
24LC08BH-I/ST  
24AA08H-I/ST  
24LC08BHT-I/MNY  
24AA08HT-I/MNY  
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24AA16/P  
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24AA16-E/SN  
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24AA16-E/P  
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24LC16BT-E/SN  
24AA16T-E/SN  
24LC16BT-E/ST  
24AA16T-E/ST  
24LC16BT-E/OT  
24AA16T-E/OT  
24LC16BH-E/MS  
24LC16BH-E/SN  
24LC16BH-E/P  
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24AA16H-I/SN